MOS FIELD EFFECT TRANSISTOR $\mu PA1951$

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

JEC

The μ PA1951 is a switching device, which can be driven directly by a 1.8 V power source.

The device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 1.8 V drive available
- Low on-state resistance
- $\begin{array}{l} {\sf R}_{DS(on)1} = 88 \mbox{ m}\Omega \mbox{ MAX. (V}_{GS} = -4.5 \mbox{V, I}_{D} = -1.5 \mbox{ A}) \\ {\sf R}_{DS(on)2} = 114 \mbox{ m}\Omega \mbox{ MAX. (V}_{GS} = -3.0 \mbox{ V, I}_{D} = -1.5 \mbox{ A}) \\ {\sf R}_{DS(on)3} = 133 \mbox{ m}\Omega \mbox{ MAX. (V}_{GS} = -2.5 \mbox{ V, I}_{D} = -1.5 \mbox{ A}) \\ {\sf R}_{DS(on)4} = 234 \mbox{ m}\Omega \mbox{ MAX. (V}_{GS} = -1.8 \mbox{ V, I}_{D} = -1.0 \mbox{ A}) \\ \end{array}$

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA1951TE	SC-95 (Mini Mold Thin Type)

Marking: TN

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	-12	V
Gate to Source Voltage (VDs = 0 V)	Vgss	∓8.0	V
Drain Current (DC)	D(DC)	∓2.5	А
Drain Current (pulse) ^{Note1}	D(pulse)	∓10	А
Total Power Dissipation (2 units) Note2	P T1	1.15	W
Total Power Dissipation (1 unit) Note2	P T2	0.57	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

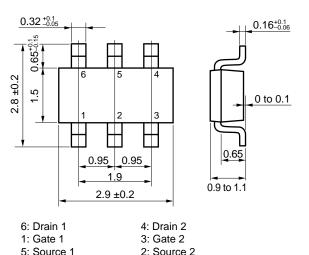
2. Mounted on FR-4 board of 5000 mm² x 1.1 mm, t \leq 5 sec.

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

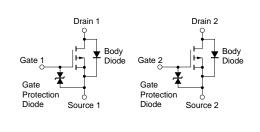
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PACKAGE DRAWING (Unit: mm)



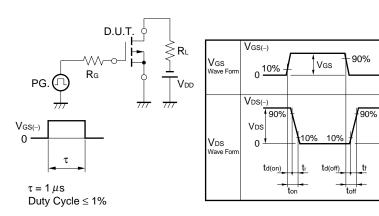
EQUIVALENT CIRCUITS



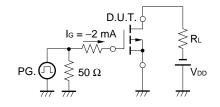
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -12 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 8.0 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			∓10	μA
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, \text{ ID} = -1.0 \text{ mA}$	-0.45	-0.75	-1.5	V
Forward Transfer Admittance	y₁s	$V_{DS} = -10 \text{ V}, \text{ ID} = -1.5 \text{ A}$	1.0	4.7		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -4.5 \text{ V}, \text{ Id} = -1.5 \text{ A}$		70	88	mΩ
	RDS(on)2	$V_{GS} = -3.0 \text{ V}, \text{ Id} = -1.5 \text{ A}$		85	114	mΩ
	RDS(on)3	Vgs = −2.5 V, Id = −1.5 A		100	133	mΩ
	RDS(on)4	$V_{GS} = -1.8 \text{ V}, \text{ Id} = -1.0 \text{ A}$		140	234	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		270		pF
Output Capacitance	Coss	Vgs = 0 V		90		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		45		pF
Turn-on Delay Time	td(on)	$V_{DD} = -6.0 \text{ V}, \text{ Id} = -1.5 \text{ A}$		14		ns
Rise Time	tr	Vgs = -4.0 V		90		ns
Turn-off Delay Time	$t_{d(off)}$	R _G = 10 Ω		150		ns
Fall Time	tr			130		ns
Total Gate Charge	QG	Vdd = -10 V		2.4		nC
Gate to Source Charge	Q _{GS}	Vgs = -4.0 V		0.6		nC
Gate to Drain Charge	Qgd	ID = -2.5 A		0.8		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 2.5 A, VGS = 0 V		0.87		V

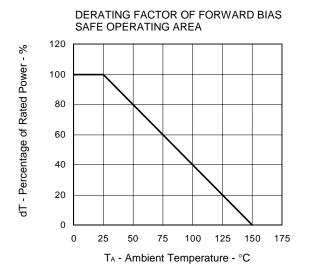
TEST CIRCUIT 1 SWITCHING TIME

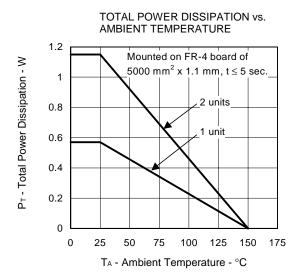


TEST CIRCUIT 2 GATE CHARGE

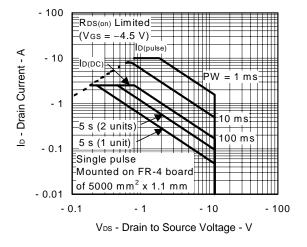


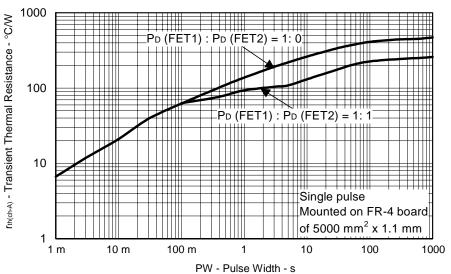
TYPICAL CHARACTERISTICS (TA = 25°C)





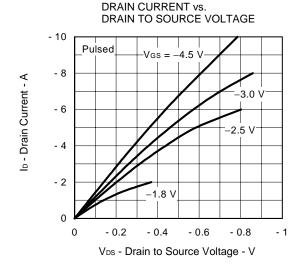
FORWARD BIAS SAFE OPERATING AREA

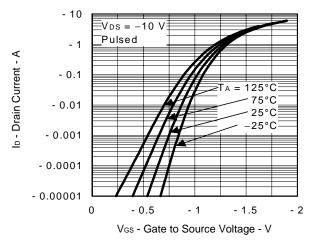




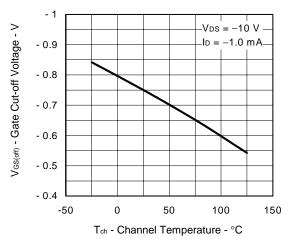
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



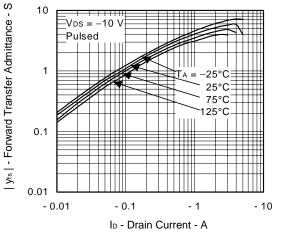




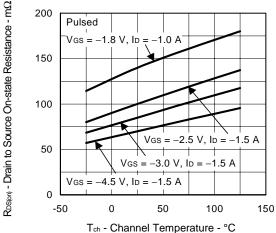
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



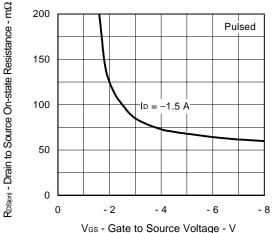
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

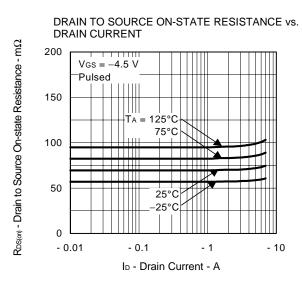


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

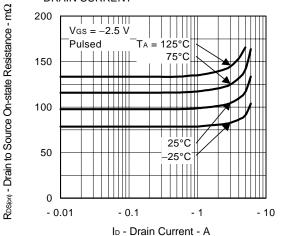


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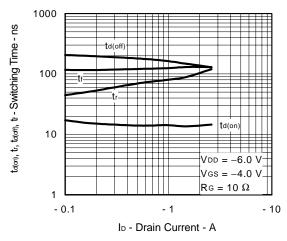
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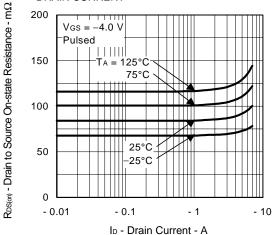




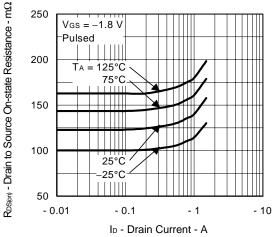




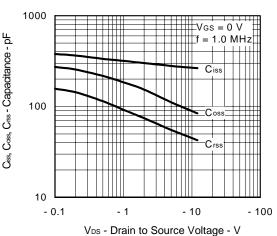
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



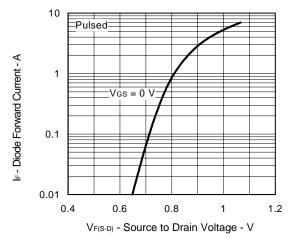
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



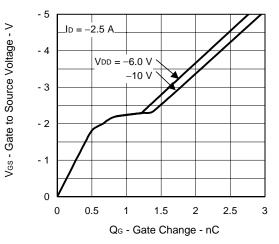
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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